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March 2011

FDMS2734

N-Channel UltraFET Trench[®] MOSFET 250V, 14A, 122m Ω

Features

- Max $r_{DS(on)}$ = 122m Ω at V_{GS} = 10V, I_D = 2.8A
- Max $r_{DS(on)}$ = 130m Ω at V_{GS} = 6V, I_D = 1.7A
- Low Miller Charge
- Optimized efficiency at high frequencies
- RoHS Compliant

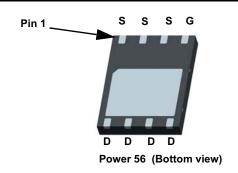
General Description

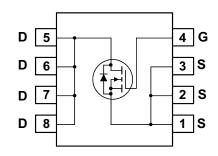
UltraFET devices combine characteristics that enable benchmark efficiency in power conversion applications. Optimized for $r_{DS(on)}$, low ESR, low total and Miller gate charge, these devices are ideal for high frequency DC to DC converters.

Application

■ DC - DC Conversion







MOSFET Maximum Ratings $T_A = 25^{\circ}C$ unless otherwise noted

Symbol	Parameter			Ratings	Units
V _{DS}	Drain to Source Voltage			250	V
V _{GS}	Gate to Source Voltage			±20	V
	Drain Current -Continuous (Silicon limited)	T _C = 25°C		14	
I _D	-Continuous	T _A = 25°C	(Note 1a)	2.8	Α
	-Pulsed			30	
D	Power Dissipation	T _C = 25°C		78	10/
P_{D}	Power Dissipation	T _A = 25°C	(Note 1a)	2.5	W
T _J , T _{STG}	Operating and Storage Junction Temperature F	Range		-55 to +150	°C

Thermal Characteristics

$R_{\theta JC}$	Thermal Resistance, Junction to Case	1.6	°C/W
$R_{\theta JA}$	Thermal Resistance, Junction to Ambient (Note 1a)	50	C/VV

Package Marking and Ordering Information

Device Marking	Device	Package	Reel Size	Tape Width	Quantity
FDMS2734	FDMS2734	Power 56	13"	12mm	3000 units

Electrical Characteristics $T_J = 25^{\circ}C$ unless otherwise noted

Symbol	Parameter	Test Conditions	Min	Тур	Max	Units
Off Chara	acteristics					
BV _{DSS}	Drain to Source Breakdown Voltage	$I_D = 250 \mu A, V_{GS} = 0 V$	250			V
$\frac{\Delta BV_{DSS}}{\Delta T_{J}}$	Breakdown Voltage Temperature Coefficient	I _D = 250μA, referenced to 25°C		250		mV/°C
I _{DSS}	Zero Gate Voltage Drain Current	V _{DS} = 200V,			1	μА
I _{GSS}	Gate to Source Leakage Current	$V_{GS} = \pm 20V, V_{GS} = 0V$			±100	nA

On Characteristics (Note 2)

V _{GS(th)}	Gate to Source Threshold Voltage	$V_{GS} = V_{DS}, I_{D} = 250 \mu A$	2	3	4	V
$\frac{\Delta V_{GS(th)}}{\Delta T_J}$	Gate to Source Threshold Voltage Temperature Coefficient	I _D = 250μA, referenced to 25°C		-11		mV/°C
r _{DS(on)}		$V_{GS} = 10V, I_D = 2.8A$		105	122	
	Drain to Source On Resistance	$V_{GS} = 6V, I_D = 1.7A$		110	130	mΩ
		$V_{GS} = 10V$, $I_D = 2.8A T_J = 125$ °C		217	258	
9 _{FS}	Forward Transconductance	$V_{DS} = 10V, I_{D} = 2.8A$		11		S

Dynamic Characteristics

C _{iss}	Input Capacitance			1775	2365	pF
C _{oss}	Output Capacitance	V _{DS} = 100V, V _{GS} = 0V, f = 1MHz		80	110	pF
C _{rss}	Reverse Transfer Capacitance	1 - 1101112		25	40	pF
R_g	Gate Resistance	f = 1MHz		0.9		Ω

Switching Characteristics

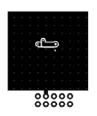
t _{d(on)}	Turn-On Delay Time		22	36	ns
t _r	Rise Time	$V_{DD} = 125V, I_{D} = 2.8A$ $V_{GS} = 10V, R_{GEN} = 6\Omega$	10	20	ns
t _{d(off)}	Turn-Off Delay Time	V _{GS} - 10V, R _{GEN} - 612	36	58	ns
t _f	Fall Time		12	22	ns
$Q_{g(TOT)}$	Total Gate Charge at 10V	$V_{GS} = 0V \text{ to } 10V V_{DD} = 125V$	30	42	nC
Q_{gs}	Gate to Source Gate Charge	I _D = 2.8A	7		nC
Q_{gd}	Gate to Drain "Miller" Charge		9		nC

Drain-Source Diode Characteristics

V_{SD}	Source to Drain Diode Forward Voltage	$V_{GS} = 0V, I_S = 2.8A$ (Note 2)		0.75	1.20	V
t _{rr}	Reverse Recovery Time	I _F = 2.8A, di/dt = 100A/μs		79	119	ns
Q _{rr}	Reverse Recovery Charge	1F - 2.6A, αι/αι - 100A/μs		214	321	nC

Notes

^{1:} R_{0JA} is determined with the device mounted on a 1 in² pad 2 oz copper pad on a 1.5 x 1.5 in. board of FR-4 material. R_{0JC} is guaranteed by design while R_{0CA} is determined by the user's board design.



a. 50°C/W when mounted on a 1 in² pad of 2 oz copper

b. 125°C/W when mounted on a minimum pad of 2 oz copper



2: Pulse Test: Pulse Width < 300 μ s, Duty cycle < 2.0%.

Typical Characteristics T_J = 25°C unless otherwise noted

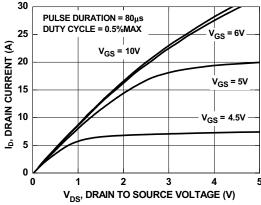


Figure 1. On Region Characteristics

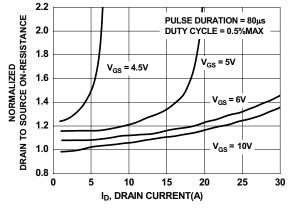


Figure 2. Normalized On-Resistance vs Drain Current and Gate Voltage

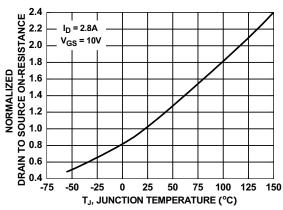


Figure 3. Normalized On Resistance vs Junction Temperature

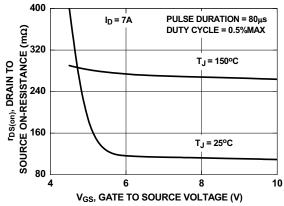


Figure 4. On-Resistance vs Gate to Source Voltage

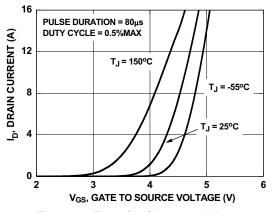


Figure 5. Transfer Characteristics

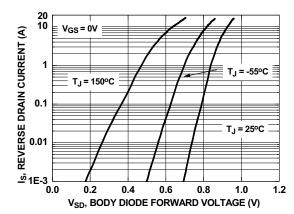


Figure 6. Source to Drain Diode Forward Voltage vs Source Current

Typical Characteristics T_J = 25°C unless otherwise noted

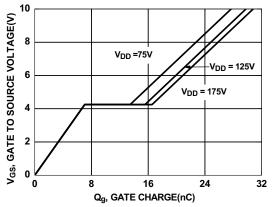
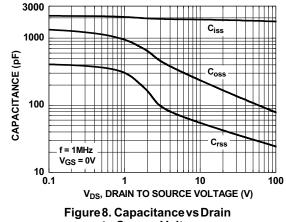


Figure 7. Gate Charge Characteristics



to Source Voltage

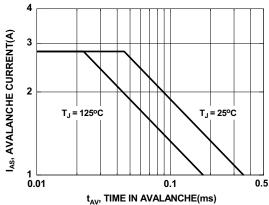


Figure 9. Unclamped Inductive **Switching Capability**

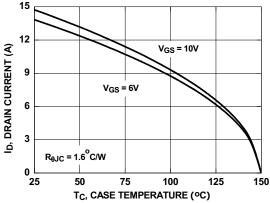


Figure 10. Maximum Continuous Drain **Current vs Case Temperature**

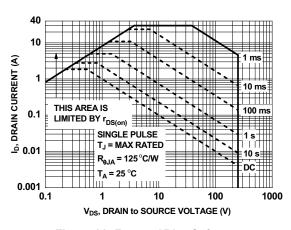


Figure 11. Forward Bias Safe **Operating Area**

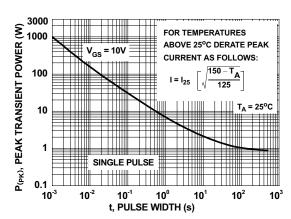


Figure 12. Single Pulse Maximum **Power Dissipation**

Typical Characteristics T_J = 25°C unless otherwise noted

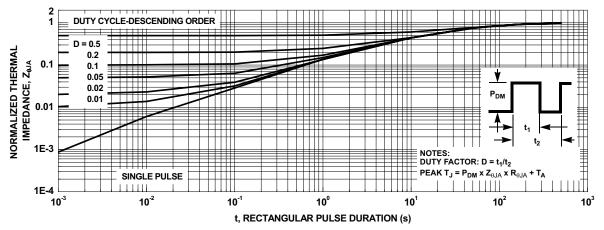
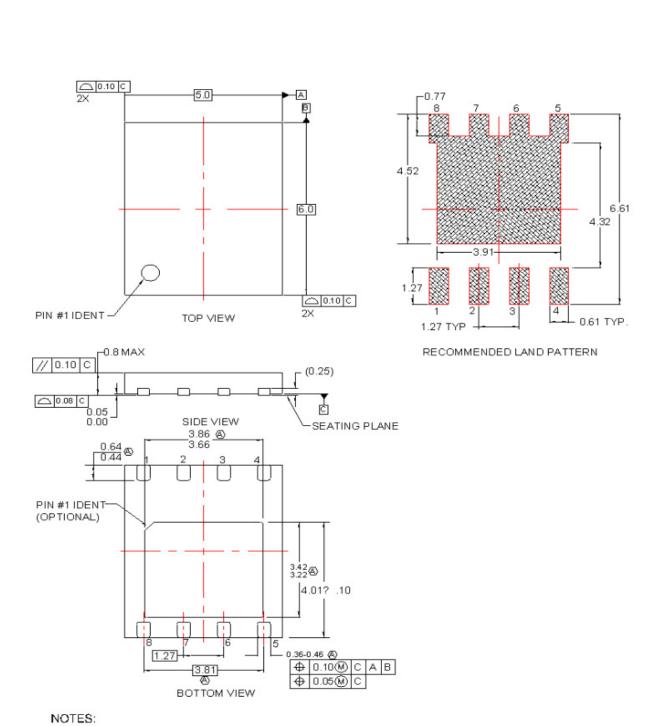


Figure 13. Transient Thermal Response Curve



- A DOES NOT FULLY CONFORM TO JEDEC REGISTRATION, MO-229. DATED 11/2001.
- B. DIMENSIONS ARE IN MILLIMETERS.
- C. DIMENSIONS AND TOLERANCES PER ASME Y14.5M, 1994
- D. TERMINALS 5,6,7 AND 8 ARE TIED TO THE EXPOSED PADDLE

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